Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/616,623	LU ET AL.	
Examiner	Art Unit	
Phallaka Kik	2825	

SEARCHED				
Class	Subclass	Date	Examiner	
716	6,7,10,13	10/11/2005	PK	
703	16	10/11/2005	PK	
Above	updated	1/25/2006	PK	
Above	new	1/25/2006	PK	
			•	

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
716	6,7,10,13	1/26/2006	PK		
703	16	1/26/2006	PK		
USPGPUB (see attached)		1/26/2006	PK		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
BRS (EAST)USPAT, USPGPUB Class/sub searched: 716/1-18; 703/14-16 (see attached)	10/11/2005	PK		
EPO, JPO, IBM TDB, Derwent (see attached)	10/11/2005	PK		
IEE/IEEE Xplore (see attached)	10/11/2005	PK		
All above new and updated search (see atached)	1/25/2006	РК		